

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/788,496	NOWAK, ANDREW F.	
Examiner		Art Unit		Page 1 of 1
David T. Fidei		3728		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,112,477 A	03-1938	WASHINGTON BROWNFIELD GEORGE	383/71
*	B	US-3,497,982 A	03-1970	SCHULZ PAUL HENRY	40/312
*	C	US-3,837,565 A	09-1974	Johnsen, Edward L.	229/301
*	D	US-4,842,140 A	06-1989	Mesnard, Curtis L.	206/457
*	E	US-4,860,899 A	08-1989	McKee, John H.	206/534
*	F	US-4,873,193 A	10-1989	Jensen et al.	436/176
*	G	US-4,955,480 A	09-1990	Sexton, Wilson C.	206/528
*	H	US-5,046,609 A	09-1991	Mangini et al.	206/232
*	I	US-5,690,246 A	11-1997	Anderson et al.	220/254.7
*	J	US-2002/0020651 A1	02-2002	McLaughlin, John R. JR.	206/459.5
K	US-				
L	US-				
M	US-				

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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